

L Number	Hits	Search Text	DB	Time stamp
-	4200	((438/17,18,11,for.101,for.102,for.142).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/28 11:14
-	4	((438/17,18,11,for.101,for.102,for.142).CCLS.) and LOCOS	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/27 13:54
-	36	((438/17,18,11,for.101,for.102,for.142).CCLS.) and field near2 (oxidat\$4 oxydat\$4 insulat\$4)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/27 14:29
-	18	((438/17,18,11,for.101,for.102,for.142).CCLS.) and fox not (((438/17,18,11,for.101,for.102,for.142).CCLS.) and field near2 (oxidat\$4 oxydat\$4 insulat\$4))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/27 14:13
-	0	(Etching etched etch) near2 substrate with (fox locos field near (oxide oxidation oxyde oxydation)) near2 mask	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/28 09:43
-	36	(Etching etched etch) near2 substrate with (fox locos field near (oxide oxidation oxyde oxydation)) near2 mask	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/27 15:06
-	5	5652458.URPN.	USPAT	2003/08/27 15:00
-	1	"5200351".PN.	USPAT	2003/08/27 15:00
-	6	5563080.URPN.	USPAT	2003/08/27 15:00
-	5	("3861024"   "3958040"   "3980508"   "4242156"   "4313256"   "4667395"   "5132238"   "5200351").PN.	USPAT	2003/08/27 15:00
-	17	(5652458.URPN. "5200351".PN. 5563080.URPN. ((("3861024"   "3958040"   "3980508"   "4242156"   "4313256"   "4667395"   "5132238"   "5200351").PN.) ) not ((Etching etched etch) near2 substrate with (fox locos field near (oxide oxidation oxyde oxydation)) near2 mask )	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/27 15:00
-	42	(Etching etched etch) near2 (silicon si) with (fox locos field near (oxide oxidation oxyde oxydation)) near2 mask	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/27 15:07
-	29	((Etching etched etch) near2 (silicon si) with (fox locos field near (oxide oxidation oxyde oxydation)) near2 mask ) not ((Etching etched etch) near2 substrate with (fox locos field near (oxide oxidation oxyde oxydation)) near2 mask )	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/27 15:07
-	8	("4639893"   "4990979"   "5021999"   "5095344"   "5723888"   "5812449"   "5851881"   "6190968").PN.	USPAT	2003/08/27 15:58
-	0	6566707.URPN.	USPAT	2003/08/27 15:59
-	4200	((438/17,18,11,for.101,for.102,for.142).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/27 16:02

-	0	(n and p) near3 (substrate silicon si) and ((438/17,18,11,for.101,for.102,for.142).CCLS.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/27 16:03
-	40	(n and p) near4 (substrate silicon si) and ((438/17,18,11,for.101,for.102,for.142).CCLS.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/27 16:08
-	83	(n and p) near2 (substrate silicon si) and ((438/17,18,11,for.101,for.102,for.142).CCLS.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/27 16:08
-	144	(n and p) near4 (substrate silicon si) and ((438/17,18,11,for.101,for.102,for.142).CCLS.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/27 16:25
-	1	electron near charge near effect	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/27 17:00
-	2	("6143579").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/27 17:01
-	0	breakdown near voltage	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/27 17:01
-	4	braekdown near voltage	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/27 17:01
-	42057	breakdown near voltage	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/27 17:02
-	7870	breakdown near voltage with current	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/27 17:03
-	1168	breakdown near voltage with current with gate	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/27 17:03
-	125	breakdown near voltage with current with gate with substrate	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/27 17:20

-	346	dry adj oxide	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/27 17:21
-	186	dry adj oxide and (438/\$6 257/\$6)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/27 17:21
-	9197	(square rectangle) with (poly si polysilicon silicon)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/28 09:41
-	4201	(438/17,18,11,for.101,for.102,for.142).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/28 09:34
-	38	((square rectangle) with (poly si polysilicon silicon)) and ((438/17,18,11,for.101,for.102,for.142).CCLS.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/28 09:38
-	2346	((square rectangle) with (poly si polysilicon silicon)) and (438/\$6 257/\$6) and (sens\$3 detect\$3 measur\$3 test\$3)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/28 09:42
-	1013	((square rectangle) with (poly si polysilicon silicon)) and (438/\$6 257/\$6) and (sens\$3 detect\$3 measur\$3 test\$3) with (poly si polysilicon silicon)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/28 09:42
-	755	((square rectangle) with (poly si polysilicon silicon)) and (438/\$6 257/\$6) and (sens\$3 detect\$3 measur\$3 test\$3) with (poly si polysilicon silicon)) and (poly si polysilicon silicon) with (pad area pattern)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/28 09:42
-	585	((square rectangle) with (poly si polysilicon silicon)) and (438/\$6 257/\$6) and (sens\$3 detect\$3 measur\$3 test\$3)) and (fox locos field near (oxide oxidation oxyde oxydation))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/28 09:43
-	124	((square rectangle) with (poly si polysilicon silicon)) and (438/\$6 257/\$6) and (sens\$3 detect\$3 measur\$3 test\$3)) and (fox locos field near (oxide oxidation oxyde oxydation)) ) and (fox locos field near (oxide oxidation oxyde oxydation)) same (square rectangle)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/28 10:26
-	124	((square rectangle) with (poly si polysilicon silicon)) and (438/\$6 257/\$6) and (sens\$3 detect\$3 measur\$3 test\$3)) and (fox locos field near (oxide oxidation oxyde oxydation)) ) and (fox locos field near (oxide oxidation oxyde oxydation)) same (square rectangle)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/28 10:29

-	51	(((square rectangle) with (poly si polysilicon silicon)) and (438/\$6 257/\$6) and (sens\$3 detect\$3 measur\$3 test\$3)) and (fox locos field near (oxide oxidation oxyde oxydation)) ) and (fox locos field near (oxide oxidation oxyde oxydation)) same (array) not (((square rectangle) with (poly si polysilicon silicon)) and (438/\$6 257/\$6) and (sens\$3 detect\$3 measur\$3 test\$3)) and (fox locos field near (oxide oxidation oxyde oxydation)) ) and (fox locos field near (oxide oxidation oxyde oxydation)) same (square rectangle) )	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/28 10:49
-	4	monitor\$3 with recycl\$3 with anneal\$3	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/28 10:50
-	4201	(438/17,18,11,for.101,for.102,for.142).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/28 11:14
-	3	((438/17,18,11,for.101,for.102,for.142).CCLS.) and (fox locos field near (oxide oxidation oxyde oxydation)) near2 mask	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/28 11:15
-	121	((438/17,18,11,for.101,for.102,for.142).CCLS.) and (fox locos field near (oxide oxidation oxyde oxydation))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/28 11:16